



RADIO TEST REPORT FCC ID: 2AOWK-5002TH

Product: Mobile Phone

Trade Mark: ulefone

Model No.: GQ5002

Family Model: Armor 12S, Armor 12, Armor 12T,

Armor 12P, Armor 12E, Armor

12X, Armor 12 Pro

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I TEST RESULT CERTIFICATION

Applicant's name	Shenzhen Gotron Electronic CO.,LTD.	
Address:	7B01, Building A, Block 1, Anhongji Tianyao Plaza, Longhua District, Shenzhen City, Guangdong Province China	
Manufacturer's Name:	Shenzhen Gotron Electronic CO.,LTD.	
Address:	7B01, Building A, Block 1, Anhongji Tianyao Plaza, Longhua District, Shenzhen City, Guangdong Province China	
Product description		
Product name:	Mobile Phone	
Trade Mark	ulefone	
Model and/or type reference:	GQ5002	
Family Model:	Armor 12S, Armor 12, Armor 12T, Armor 12P, Armor 12E, Armor 12X, Armor 12 Pro	
Test Sample number:	T221008001R004	

Measurement Procedure Used:

APPLICABLE STANDARDS			
APPLICABLE STANDARD/ TEST PROCEDURE	TEST RESULT		
FCC 47 CFR Part 2, Subpart J			
FCC 47 CFR Part 15, Subpart C	Complied		
ANSI C63.10-2013	Complied		
KDB 558074 D01 15.247 Meas Guidance v05r02			

This device described above has been tested by Shenzhen NTEK Testing Technology Co., Ltd., and the test results show that the equipment under test (EUT) is in compliance with the FCC requirements. And it is applicable only to the tested sample identified in the report.

This report shall not be reproduced except in full, without the written approval of Shenzhen NTEK Testing Technology Co., Ltd., this document may be altered or revised by Shenzhen NTEK Testing Technology Co., Ltd., personnel only, and shall be noted in the revision of the document.

The test results of this report relate only to the tested sample identified in this report.

Date of Test	: Oct 08, 2022 ~ Nov 21, 2022
Testing Engineer	Muhri Lee
	(Mukzi Lee)
Authorized Signatory	Alex
ŭ ,	(Alex Li)

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SUMMARY OF TEST RESULTS

FCC Part15 (15.247), Subpart C						
Standard Section Test Item Verdict F						
15.207	Conducted Emission	PASS				
15.247 (a)(2)	6dB Bandwidth	PASS				
15.247 (b)	Peak Output Power	PASS				
15.209 (a) 15.205 (a)	Radiated Spurious Emission	PASS				
15.247 (e)	Power Spectral Density	PASS				
15.247 (d)	Band Edge Emission	PASS				
15.247 (d)	Spurious RF Conducted Emission	PASS				
15.203	Antenna Requirement	PASS				

Remark:

- "N/A" denotes test is not applicable in this Test Report.
 All test items were verified and recorded according to the standards and without any deviation during the test.

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3 FACILITIES AND ACCREDITATIONS

3.1 **FACILITIES**

All measurement facilities used to collect the measurement data are located at

1/F, Building E, Fenda Science Park, Sanwei Community, Xixiang Street, Bao'an District, Shenzhen 518126 P.R. China

The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.10 and CISPR Publication 22.

3.2 LABORATORY ACCREDITATIONS AND LISTINGS

Site Description

CNAS-Lab. : The Certificate Registration Number is L5516. IC-Registration The Certificate Registration Number is 9270A.

CAB identifier: CN0074

FCC- Accredited Test Firm Registration Number: 463705.

Designation Number: CN1184

A2LA-Lab. The Certificate Registration Number is 4298.01

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General requirements for

the competence of testing and calibration laboratories.

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated 8 January 2009).

Name of Firm : Shenzhen NTEK Testing Technology Co., Ltd.

Site Location : 1/F, Building E, Fenda Science Park, Sanwei Community, Xixiang

Street, Bao'an District, Shenzhen 518126 P.R. China.

3.3 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement y±U, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95 %.

No.	Item	Uncertainty
1	Conducted Emission Test	±2.80dB
2	RF power, conducted	±0.16dB
3	Spurious emissions, conducted	±0.21dB
4	All emissions, radiated(30MHz~1GHz)	±2.64dB
5	All emissions, radiated(1GHz~6GHz)	±2.40dB
6	All emissions, radiated(>6GHz)	±2.52dB
7	Temperature	±0.5°C
8	Humidity	±2%
9	All emissions, radiated(9KHz~30MHz)	±6dB

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4 GENERAL DESCRIPTION OF EUT

Product Feature and Specification				
Equipment	Mobile Phone			
Trade Mark	ulefone			
FCC ID	2AOWK-5002TH			
Model No.	GQ5002			
Family Model	Armor 12S, Armor 12, Armor 12T, Armor 12P, Armor 12E, Armor 12X, Armor 12 Pro			
Model Difference	All the model are the same circuit and RF module, except the model names.			
Operating Frequency	2402MHz~2480MHz			
Modulation	GFSK			
Number of Channels	40 Channels			
Antenna Type	PIFA Antenna			
Antenna Gain	-0.6 dBi			
Adapter	Model: HJ-FC038K7-US Input: 100-240V~50/60Hz 0.6A Output: 5V3.0A OR 9V2.0A OR 12V1.5A			
Battery	DC 3.85V, 5180mAh, 19.94Wh			
Power supply	DC 3.85V from battery or DC 5V from adapter			
HW Version	A200H_02			
SW Version Armor 12S_TH1_EEA_V01				

Note 1: Based on the application, features, or specification exhibited in User's Manual, the EUT is considered as an ITE/Computing Device. More details of EUT technical specification, please refer to the User's Manual.

Note 2: The engineering test program was provided and the EUT was programmed to be in continuously transmitting mode.

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Revision History

Report No.	Version	Description	Issued Date
STR221008002002E	Rev.01	Initial issue of report	Nov 21, 2022

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5 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

The Transmitter was operated in the normal operating mode. The TX frequency was fixed which was for the purpose of the measurements.

Test of channel included the lowest and middle and highest frequency to perform the test, then record on this report.

Those data rates (1Mbps/2Mbps for GFSK modulation) were used for all test.

The EUT was pretested with 3 orientations placed on the table for the radiated emission measurement –X, Y, and Z-plane. The X-plane results were found as the worst case and were shown in this report.

Carrier Frequency and Channel list:

Channel	Frequency(MHz)
0	2402
1	2404
	•••
19	2440
20	2442
	•••
38	2478
39	2480

Note: fc=2402MHz+k×2MHz k=0 to 39

The following summary table is showing all test modes to demonstrate in compliance with the standard.

The following summary table is showing all test modes to demonstrate in compliance with the standard.					
Test Cases					
Test Item	Data Rate/ Modulation				
AC Conducted Emission	Mode 1: normal link mode				
	Mode 1: normal link mode				
Radiated Test	Mode 2: GFSK Tx Ch00_2402MHz_1Mbps/2Mbps				
Cases	Mode 3: GFSK Tx Ch19_2440MHz_1Mbps/2Mbps				
	Mode 4: GFSK Tx Ch39_2480MHz_1Mbps/2Mbps				
Conducted Test	Mode 2: GFSK Tx Ch00_2402MHz_1Mbps/2Mbps				
Conducted Test Cases	Mode 3: GFSK Tx Ch19_2440MHz_1Mbps/2Mbps				
Cases	Mode 4: GFSK Tx Ch39_2480MHz_1Mbps/2Mbps				

Note:

- 1. The engineering test program was provided and the EUT was programmed to be in continuously transmitting mode(duty cycle =100% during the test)
- 2. AC power line Conducted Emission was tested under maximum output power.
- 3. For radiated test cases, the worst mode data rate 2Mbps was reported only, because this data rate has the highest RF output power at preliminary tests, and no other significantly frequencies found in conducted spurious emission.
- 4. EUT built-in battery-powered, the battery is fully-charged.

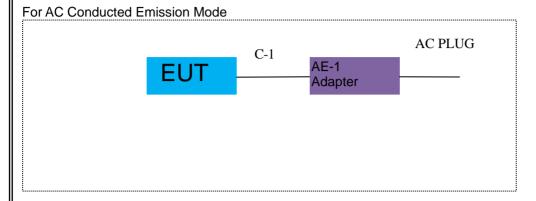
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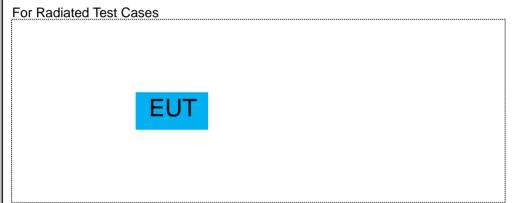


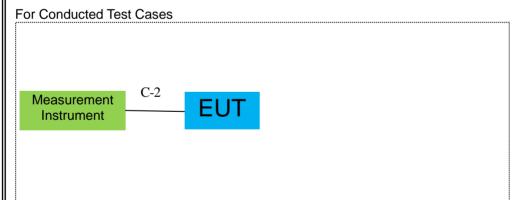


6 SETUP OF EQUIPMENT UNDER TEST

6.1 BLOCK DIAGRAM CONFIGURATION OF TEST SYSTEM







Note: The temporary antenna connector is soldered on the PCB board in order to perform conducted tests and this temporary antenna connector is listed in the equipment list.

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6.2 **SUPPORT EQUIPMENT**

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests

Item	Equipment	Model/Type No.	Series No.	Note
AE-1	Adapter	HJ-FC038K7-US	N/A	Peripherals

Item	Cable Type	Shielded Type	Ferrite Core	Length
C-1	USB Cable	NO	NO	1.0m
C-2	RF Cable	YES	NO	0.1m

Notes:

- (1) The support equipment was authorized by Declaration of Confirmation.
- (2) For detachable type I/O cable should be specified the length in cm in <code>[Length]</code> column.
- (3) "YES" is means "shielded" "with core"; "NO" is means "unshielded" "without core".

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6.3 EQUIPMENTS LIST FOR ALL TEST ITEMS

Radiation& Conducted Test equipment

<u>Radiatio</u>	adiation& Conducted Test equipment						
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibrati on period
1	Spectrum Analyzer	Aglient	E4407B	MY45108040	2022.04.01	2023.03.31	1 year
2	Spectrum Analyzer	Agilent	N9020A	MY49100060	2022.04.01	2023.03.31	1 year
3	Spectrum Analyzer	R&S	FSV40	101417	2022.06.16	2023.06.15	1 year
4	Test Receiver	R&S	ESPI7	101318	2022.04.06	2023.04.05	1 year
5	Bilog Antenna	TESEQ	CBL6111D	31216	2022.03.30	2023.03.29	1 year
6	50Ω Coaxial Switch	Anritsu	MP59B	6200983705	2020.05.11	2023.05.10	3 year
7	Horn Antenna	EM	EM-AH-1018 0	2011071402	2022.03.31	2023.03.30	1 year
8	Broadband Horn Antenna	SCHWARZBE CK	BBHA 9170	803	2021.11.07 2022.11.07	2022.11.06 2023.11.06	1 year
9	Amplifier	EMC	EMC051835 SE	980246	2022.06.17	2023.06.16	1 year
10	Active Loop Antenna	SCHWARZBE CK	FMZB 1519 B	055	2021.11.07 2022.11.04	2022.11.06 2023.11.03	1 year
11	Power Meter	DARE	RPR3006W	15I00041SN O84	2022.06.16	2023.06.15	1 year
12	Test Cable (9KHz-30MHz)	N/A	R-01	N/A	2022.06.17	2025.06.16	3 year
13	Test Cable (30MHz-1GHz)	N/A	R-02	N/A	2022.06.17	2025.06.16	3 year
14	High Test Cable(1G-40G Hz)	N/A	R-03	N/A	2022.06.17	2025.06.16	3 year
15	Filter	TRILTHIC	2400MHz	29	2020.04.07	2023.04.06	3 year
16	temporary antenna connector (Note)	NTS	R001	N/A	N/A	N/A	N/A

Note:

We will use the temporary antenna connector (soldered on the PCB board) When conducted test And this temporary antenna connector is listed within the instrument list

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۸С	Conduction	Toct	aquinment
AC	Conduction	rest	edulpment

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Test Receiver	R&S	ESCI	101160	2022.04.06	2023.04.05	1 year
2	LISN	R&S	ENV216	101313	2022.04.06	2023.04.05	1 year
3	LISN	SCHWARZBE CK	NNLK 8129	8129245	2022.04.06	2023.04.05	1 year
4	50Ω Coaxial Switch	ANRITSU CORP	MP59B	6200983704	2020.05.11	2023.05.10	3 year
5	Test Cable (9KHz-30MH z)	N/A	C01	N/A	2020.05.11	2023.05.10	3 year
6	Test Cable (9KHz-30MH z)	N/A	C02	N/A	2020.05.11	2023.05.10	3 year
7	Test Cable (9KHz-30MH z)	N/A	C03	N/A	2020.05.11	2023.05.10	3 year

Note: Each piece of equipment is scheduled for calibration once a year except the Aux Equipment & Test Cable which is scheduled for calibration every 2 or 3 years.

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7 TEST REQUIREMENTS

7.1 CONDUCTED EMISSIONS TEST

7.1.1 Applicable Standard

According to FCC Part 15.207(a)

7.1.2 Conformance Limit

Fraguanov/MHz)	Conducted Emission Limit		
Frequency(MHz)	Quasi-peak	Average	
0.15-0.5	66-56*	56-46*	
0.5-5.0	56	46	
5.0-30.0	60	50	

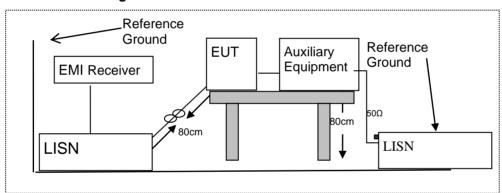
Note: 1. *Decreases with the logarithm of the frequency

- 2. The lower limit shall apply at the transition frequencies
- 3. The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50MHz.

7.1.3 Measuring Instruments

The Measuring equipment is listed in the section 6.3 of this test report.

7.1.4 Test Configuration



7.1.5 Test Procedure

According to the requirements in Section 13.1.4.1 of ANSI C63.10-2013 Conducted emissions the EUT measured in the frequency range between 0.15 MHz and 30 MHz using CISPR Quasi-Peak and average detector mode.

- 1. The EUT was placed 0.4 meter from the conducting wall of the shielding room.
- 2. The EUT was placed on a table which is 0.8m above ground plane.
- 3. Connect EUT to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- 4. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40cm long.
- 5. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- 6. LISN at least 80 cm from nearest part of EUT chassis.
- 7. The frequency range from 150KHz to 30MHz was searched.
- 8. Set the test-receiver system to Peak Detect Function and specified bandwidth(IF bandwidth=9KHz) with Maximum Hold Mode
- 9. For the actual test configuration, please refer to the related Item –EUT Test Photos.

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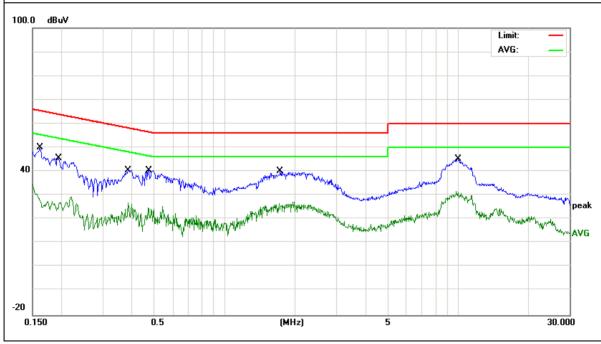
7.1.6 Test Results

EUT:	Mobile Phone	Model Name:	GQ5002
Temperature:	22 ℃	Relative Humidity:	57%
Pressure:	1010hPa	Phase :	L
TAST VOITAGE .	DC 5V from Adapter AC 120V/60Hz	Test Mode:	Mode 1

Frequency	Reading Level	Correct Factor	Measure-ment	Limits	Margin	Domork
(MHz)	(dBµV)	(dB)	(dBµV)	(dBµV)	(dB)	Remark
0.1620	40.53	9.61	50.14	65.36	-15.22	QP
0.1620	18.14	9.61	27.75	55.36	-27.61	AVG
0.1940	35.99	9.61	45.60	63.86	-18.26	QP
0.1940	16.34	9.61	25.95	53.86	-27.91	AVG
0.3860	30.81	9.65	40.46	58.15	-17.69	QP
0.3860	17.33	9.65	26.98	48.15	-21.17	AVG
0.4711	30.88	9.66	40.54	56.49	-15.95	QP
0.4711	12.83	9.66	22.49	46.49	-24.00	AVG
1.7258	30.46	9.67	40.13	56.00	-15.87	QP
1.7258	15.24	9.67	24.91	46.00	-21.09	AVG
9.9977	35.34	9.93	45.27	60.00	-14.73	QP
9.9977	20.70	9.93	30.63	50.00	-19.37	AVG

Remark:

- 1. All readings are Quasi-Peak and Average values.
- 2. Factor = Insertion Loss + Cable Loss.



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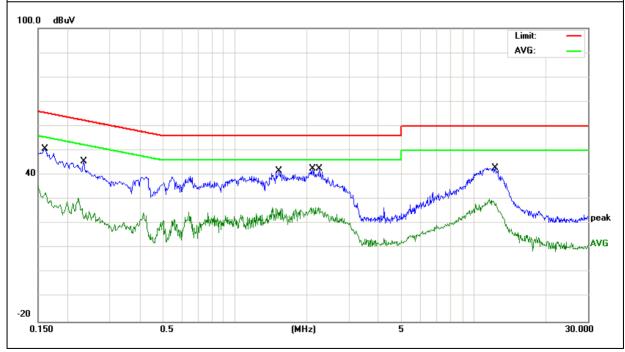


EUT:	Mobile Phone	Model Name:	GQ5002
Temperature:	22℃	Relative Humidity:	57%
Pressure:	1010hPa	Phase :	N
TEST VOUZOE •	DC 5V from Adapter AC 120V/60Hz	Test Mode:	Mode 1

Frequency	Reading Level	Correct Factor	Measure-ment	Limits	Margin	Damark
(MHz)	(dBµV)	(dB)	(dBµV)	(dBµV)	(dB)	Remark
0.1607	41.00	9.65	50.65	65.42	-14.77	QP
0.1607	22.94	9.65	32.59	55.42	-22.83	AVG
0.2340	36.01	9.62	45.63	62.30	-16.67	QP
0.2340	12.40	9.62	22.02	52.30	-30.28	AVG
1.5300	32.07	9.67	41.74	56.00	-14.26	QP
1.5300	14.67	9.67	24.34	46.00	-21.66	AVG
2.1179	32.75	9.67	42.42	56.00	-13.58	QP
2.1179	14.86	9.67	24.53	46.00	-21.47	AVG
2.2540	32.82	9.67	42.49	56.00	-13.51	QP
2.2540	14.61	9.67	24.28	46.00	-21.72	AVG
12.2659	32.85	9.97	42.82	60.00	-17.18	QP
12.2659	17.55	9.97	27.52	50.00	-22.48	AVG

Remark:

- 1. All readings are Quasi-Peak and Average values.
- 2. Factor = Insertion Loss + Cable Loss.



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7.2 RADIATED SPURIOUS EMISSION

7.2.1 Applicable Standard

According to FCC Part 15.247(d) and 15.209 and ANSI C63.10-2013

7.2.2 Conformance Limit

According to FCC Part 15.247(d): radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)). According to FCC Part15.205. Restricted bands

According to 1 CC 1 at 13.203, Restricted bands					
MHz	MHz	MHz	GHz		
0.090-0.110	16.42-16.423	399.9-410	4.5-5.15		
0.495-0.505	16.69475-16.69525	608-614	5.35-5.46		
2.1735-2.1905	16.80425-16.80475	960-1240	7.25-7.75		
4.125-4.128	25.5-25.67	1300-1427	8.025-8.5		
4.17725-4.17775	37.5-38.25	1435-1626.5	9.0-9.2		
4.20725-4.20775	73-74.6	1645.5-1646.5	9.3-9.5		
6.215-6.218	74.8-75.2	1660-1710	10.6-12.7		
6.26775-6.26825	123-138	2200-2300	14.47-14.5		
8.291-8.294	149.9-150.05	2310-2390	15.35-16.2		
8.362-8.366	156.52475-156.52525	2483.5-2500	17.7-21.4		
8.37625-8.38675	156.7-156.9	2690-2900	22.01-23.12		
8.41425-8.41475	162.0125-167.17	3260-3267	23.6-24.0		
12.29-12.293	167.72-173.2	3332-3339	31.2-31.8		
12.51975-12.52025	240-285	3345.8-3358	36.43-36.5		
12.57675-12.57725	322-335.4	3600-4400	(2)		
13.36-13.41					

20dBc in any 100 kHz bandwidth outside the operating frequency band. In case the emission fall within the restricted band specified on 15.205(a), then the 15.209(a) limit in the table below has to be followed.

confered band openined on relicoday, then the relicoday infiniting the table below had to be relieved.				
Restricted Frequency(MHz)	Field Strength (µV/m)	Field Strength (dBµV/m)	Measurement Distance	
0.009~0.490	2400/F(KHz)	20 log (uV/m)	300	
0.490~1.705	24000/F(KHz)	20 log (uV/m)	30	
1.705~30.0	30	29.5	30	
30-88	100	40	3	
88-216	150	43.5	3	
216-960	200	46	3	
Above 960	500	54	3	

Limits of Radiated Emission Measurement(Above 1000MHz)

Erogueney(MHz)	Class B (dBuV/m) (at 3M)		
Frequency(MHz)	PEAK	AVERAGE	
Above 1000	74	54	

Remark :1. Emission level in dBuV/m=20 log (uV/m)

- 2. Measurement was performed at an antenna to the closed point of EUT distance of meters.
- 3. For Frequency 9kHz~30MHz: Distance extrapolation factor =40log(Specific distance/ test distance)(dB); Limit line=Specific limits(dBuV) + distance extrapolation factor.

For Frequency above 30MHz: Distance extrapolation factor =20log(Specific distance/ test distance)(dB); Limit line=Specific limits(dBuV) + distance extrapolation factor.

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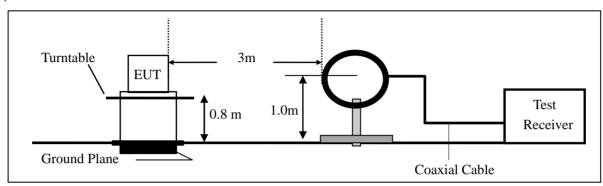


7.2.3 Measuring Instruments

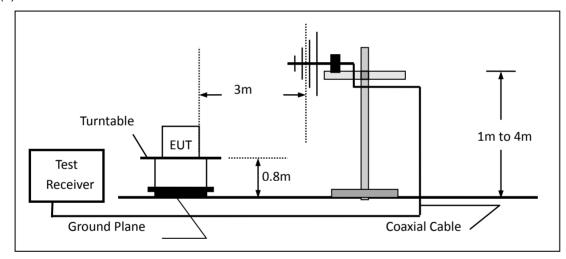
The Measuring equipment is listed in the section 6.3 of this test report.

7.2.4 Test Configuration

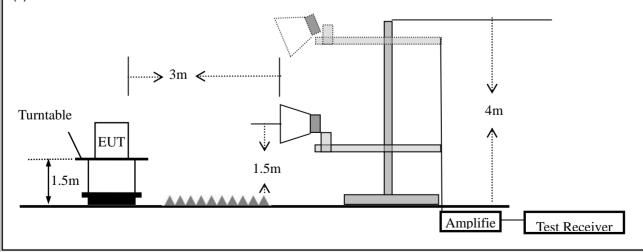
(a) For radiated emissions below 30MHz



(b) For radiated emissions from 30MHz to 1000MHz



(c) For radiated emissions above 1000MHz



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7.2.5 Test Procedure

The test site semi-anechoic chamber has met the requirement of NSA tolerance 4 dB according to the standards: ANSI C63.10-2013. The test distance is 3m. The setup is according to the requirements in Section 13.1.4.1 of ANSI C63.10-2013 and CAN/CSA-CEI/IEC CISPR 22.

This test is required for any spurious emission that falls in a Restricted Band, as defined in Section 15.205. It must be performed with the highest gain of each type of antenna proposed for use with the EUT. Use the following spectrum analyzer settings:

Spectrum Parameter	Setting
Attenuation	Auto
Start Frequency	1000 MHz
Stop Frequency	10th carrier harmonic
RB / VB (emission in restricted band)	1 MHz / 1 MHz for Peak, 1 MHz / 1MHz for Average

Receiver Parameter	Setting
Attenuation	Auto
Start ~ Stop Frequency	9kHz~150kHz / RB 200Hz for QP
Start ~ Stop Frequency	150kHz~30MHz / RB 9kHz for QP
Start ~ Stop Frequency	30MHz~1000MHz / RB 120kHz for QP

- a. The measuring distance of at 3 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- b. The EUT was placed on the top of a rotating table 0.8 m for below 1GHz and 1.5m for above 1GHz the ground at a 3 meter. The table was rotated 360 degrees to determine the position of the highest radiation.
- c. The height of the equipment or of the substitution antenna shall be 0.8 m for below 1GHz and 1.5m for above 1GHz; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For the radiated emission test above 1GHz: Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.
- e. The initial step in collecting conducted emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- f. If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.
- g. For the actual test configuration, please refer to the related Item -EUT Test Photos.

Note:

Both horizontal and vertical antenna polarities were tested and performed pretest to three orthogonal axis. The worst case emissions were reported

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During the radiated emission test, the Spectrum Analyzer was set with the following configurations:

Frequency Band (MHz)	Function	Resolution bandwidth	Video Bandwidth	
30 to 1000	30 to 1000 QP		300 kHz	
Above 1000	Peak	1 MHz	1 MHz	
Above 1000	Average	1 MHz	1 MHz	

Note: for the frequency ranges below 30 MHz, a narrower RBW is used for these ranges but the measured value should add a RBW correction factor (RBWCF) where RBWCF [dB] =10*lg(100 [kHz]/narrower RBW [kHz]). , the narrower RBW is 1 kHz and RBWCF is 20 dB for the frequency 9 kHz to 150 kHz, and the narrower RBW is 10 kHz and RBWCF is 10 dB for the frequency 150 kHz to 30 MHz.

7.2.6 Test Results

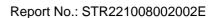
■ Spurious Emission below 30MHz (9KHz to 30MHz)

EUT:	Mobile Phone	Model No.:	GQ5002				
Temperature:	20 ℃	Relative Humidity:	48%				
Test Mode:	Mode1/Mode2/Mode3/ Mode4	Test By:	Mukzi Lee				

Freq.	Ant.Pol.	Emission L	evel(dBuV/m)	Limit 3	m(dBuV/m)	Over(dB)	
(MHz)	H/V	PK AV		PK	AV	PK	AV

Note: the amplitude of spurious emission that is attenuated by more than 20dB below the permissible limit has no need to be reported.

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Spurious Emission below 1GHz (30MHz to 1GHz)
All the modulation modes have been tested, and the worst result was report as below:

EUT:	Mobile Phone	Model Name:	GQ5002
Temperature:	25 ℃	Relative Humidity:	55%
Pressure:	1010hPa	Test Mode:	Mode 3
Test Voltage:	DC 3.85V		

Polar	Frequency	Meter Reading	Factor	Emission Level	I I Imits I Margin		Remark	
(H/V)	(MHz)	(dBuV)	(dB)	(dBuV/m)	(dBuV/m)	(dB)	rtomant	
V	31.1798	6.99	25.66	32.65	40.00	-7.35	QP	
V	46.8303	12.73	16.60	29.33	40.00	-10.67	QP	
V	68.3906	17.42	13.22	30.64	40.00	-9.36	QP	
V	154.2786	15.52	18.51	34.03	43.50	-9.47	QP	
V	186.4404	15.51	16.63	32.14	43.50	-11.36	QP	
V	945.4397	6.74	31.13	37.87	46.00	-8.13	QP	

Remark:

Emission Level= Meter Reading+ Factor, Margin= Emission Level - Limit



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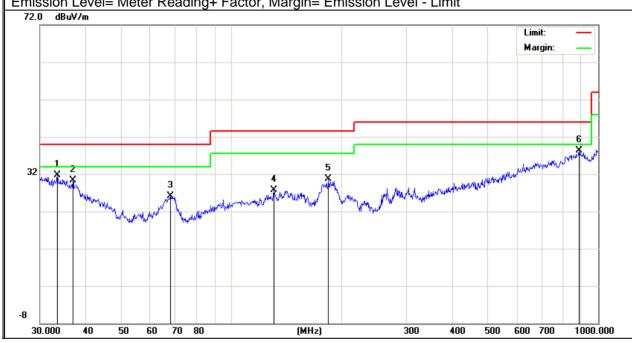




Polar	Frequency	Meter Reading	Factor Emission Limits Margin (dB) (dBuV/m) (dBuV/m) (dB)		Remark		
(H/V)	(MHz)	(dBuV)			(dBuV/m)	(dB)	
Н	33.4448	7.62	24.05	31.67	40.00	-8.33	QP
Н	36.8952	7.90	22.36	30.26	40.00	-9.74	QP
Н	68.1512	12.96	13.17	26.13	40.00	-13.87	QP
Н	130.3788	8.73	19.03	27.76	43.50	-15.74	QP
Н	183.8437	13.96	16.67	30.63	43.50	-12.87	QP
Н	887.6099	7.86	30.37	38.23	46.00	-7.77	QP

Remark:

Emission Level= Meter Reading+ Factor, Margin= Emission Level - Limit



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■ Spurious Emission Above 1GHz (1GHz to 25GHz)

EUT:	Mobile Phone	Model No.:	GQ5002
Temperature:	20 ℃	Relative Humidity:	48%
Test Mode:	Mode2/Mode3/Mode4	Test By:	Mukzi Lee

			ı		1	1				
Frequency	Read Level	Cable loss	Antenna Factor	Preamp Factor	Emission Level	Limits	Margin	Remark	Comment	
(MHz)	(dBµV)	(dB)	dB/m	(dB)	(dBµV/m)	(dBµV/m)	(dB)			
Low Channel (2402 MHz)(GFSK)Above 1G										
4804	69.82	5.21	35.59	44.30	66.32	74.00	-7.68	Pk	Vertical	
4804	47.68	5.21	35.59	44.30	44.18	54.00	-9.82	AV	Vertical	
7206	69.53	6.48	36.27	44.60	67.68	74.00	-6.32	Pk	Vertical	
7206	46.99	6.48	36.27	44.60	45.14	54.00	-8.86	AV	Vertical	
4804	70.54	5.21	35.55	44.30	67.00	74.00	-7.00	Pk	Horizontal	
4804	45.9	5.21	35.55	44.30	42.36	54.00	-11.64	AV	Horizontal	
7206	69.93	6.48	36.27	44.52	68.16	74.00	-5.84	Pk	Horizontal	
7206	50.13	6.48	36.27	44.52	48.36	54.00	-5.64	AV	Horizontal	
			Mid (Channel (244	10 MHz)(GFSI	<)Above 1G				
4880	68.02	5.21	35.66	44.20	64.69	74.00	-9.31	Pk	Vertical	
4880	47.07	5.21	35.66	44.20	43.74	54.00	-10.26	AV	Vertical	
7320	69.84	7.10	36.50	44.43	69.01	74.00	-4.99	Pk	Vertical	
7320	48.4	7.10	36.50	44.43	47.57	54.00	-6.43	AV	Vertical	
4880	68.69	5.21	35.66	44.20	65.36	74.00	-8.64	Pk	Horizontal	
4880	48.55	5.21	35.66	44.20	45.22	54.00	-8.78	AV	Horizontal	
7320	68.7	7.10	36.50	44.43	67.87	74.00	-6.13	Pk	Horizontal	
7320	46.22	7.10	36.50	44.43	45.39	54.00	-8.61	AV	Horizontal	
			High	Channel (248	30 MHz)(GFSI	K) Above 1G	i			
4960	68.51	5.21	35.52	44.21	65.03	74.00	-8.97	Pk	Vertical	
4960	49.07	5.21	35.52	44.21	45.59	54.00	-8.41	AV	Vertical	
7440	70.28	7.10	36.53	44.60	69.31	74.00	-4.69	Pk	Vertical	
7440	47.29	7.10	36.53	44.60	46.32	54.00	-7.68	AV	Vertical	
4960	70.54	5.21	35.52	44.21	67.06	74.00	-6.94	Pk	Horizontal	
4960	45.73	5.21	35.52	44.21	42.25	54.00	-11.75	AV	Horizontal	
7440	68.24	7.10	36.53	44.60	67.27	74.00	-6.73	Pk	Horizontal	
7440	46.74	7.10	36.53	44.60	45.77	54.00	-8.23	AV	Horizontal	

Note:

- (1) Emission Level= Antenna Factor + Cable Loss + Read Level Preamp Factor
- (2) All other emissions more than 20dB below the limit.
- (3)Only the worst data is recorded in the report, the data rates (2Mbps for GFSK modulation) test result is the worst

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■ Spurious Emission in Restricted Band 2310-2390MHz and 2483.5-2500MHz

EUT:	Mobile Phone	Model No.:	GQ5002
Temperature:	20 ℃	Relative Humidity:	48%
Test Mode:	Mode2/ Mode4	Test By:	Mukzi Lee

Frequency	Meter Reading	Cable Loss	Antenna Factor	Preamp Factor	Emission Level	Limits	Margin	Detector	Comment
(MHz)	(dBµV)	(dB)	dB/m	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Туре	
				1Mbp	s(GFSK)				
2310.00	70.83	2.97	27.80	43.80	57.80	74	-16.20	Pk	Horizontal
2310.00	50.86	2.97	27.80	43.80	37.83	54	-16.17	AV	Horizontal
2310.00	70.14	2.97	27.80	43.80	57.11	74	-16.89	Pk	Vertical
2310.00	47.05	2.97	27.80	43.80	34.02	54	-19.98	AV	Vertical
2390.00	68.69	3.14	27.21	43.80	55.24	74	-18.76	Pk	Vertical
2390.00	50.57	3.14	27.21	43.80	37.12	54	-16.88	AV	Vertical
2390.00	68.23	3.14	27.21	43.80	54.78	74	-19.22	Pk	Horizontal
2390.00	47.68	3.14	27.21	43.80	34.23	54	-19.77	AV	Horizontal
2483.50	70.18	3.58	27.70	44.00	57.46	74	-16.54	Pk	Vertical
2483.50	45.38	3.58	27.70	44.00	32.66	54	-21.34	AV	Vertical
2483.50	69.7	3.58	27.70	44.00	56.98	74	-17.02	Pk	Horizontal
2483.50	46.96	3.58	27.70	44.00	34.24	54	-19.76	AV	Horizontal

Note: (1) All other emissions more than 20dB below the limit.

(2)Only the worst data is recorded in the report, the data rates (2Mbps for GFSK modulation) test result is the worst

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■ Spurious Emission in Restricted Band 3260MHz-18000MHz

EUT:	Mobile Phone	Model No.:	GQ5002
Temperature:	20 ℃	Relative Humidity:	48%
Test Mode:	Mode2/ Mode4	Test By:	Mukzi Lee

Frequency	Reading Level	Cable Loss	Antenna Factor	Preamp Factor	Emission Level	Limits	Margin	Detector	Comment
(MHz)	(dBµV)	(dB)	dB/m	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Туре	
3260	69.79	4.04	29.57	44.70	58.70	74	-15.30	Pk	Vertical
3260	49.05	4.04	29.57	44.70	37.96	54	-16.04	AV	Vertical
3260	70.34	4.04	29.57	44.70	59.25	74	-14.75	Pk	Horizontal
3260	48.94	4.04	29.57	44.70	37.85	54	-16.15	AV	Horizontal
3332	70.55	4.26	29.87	44.40	60.28	74	-13.72	Pk	Vertical
3332	45.97	4.26	29.87	44.40	35.70	54	-18.30	AV	Vertical
3332	68.7	4.26	29.87	44.40	58.43	74	-15.57	Pk	Horizontal
3332	45.34	4.26	29.87	44.40	35.07	54	-18.93	AV	Horizontal
17797	57.67	10.99	43.95	43.50	69.11	74	-4.89	Pk	Vertical
17797	38.5	10.99	43.95	43.50	49.94	54	-4.06	AV	Vertical
17788	54.04	11.81	43.69	44.60	64.94	74	-9.06	Pk	Horizontal
17788	39.56	11.81	43.69	44.60	50.46	54	-3.54	AV	Horizontal

Note: (1) All other emissions more than 20dB below the limit.

(2)Only the worst data is recorded in the report, the data rates (2Mbps for GFSK modulation) test result is the worst

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7.3 6DB BANDWIDTH

7.3.1 Applicable Standard

According to FCC Part 15.247(a)(2) and KDB 558074 D01 15.247 Meas Guidance v05r02 Section 8.2.

7.3.2 Conformance Limit

The minimum permissible 6dB bandwidth is 500 kHz.

7.3.3 Measuring Instruments

The Measuring equipment is listed in the section 6.3 of this test report.

7.3.4 Test Setup

Please refer to Section 6.1 of this test report.

7.3.5 Test Procedure

The testing follows Subclause 11.8 of ANSI C63.10

The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator.

The path loss was compensated to the results for each measurement.

Set to the maximum power setting and enable the EUT transmit continuously.

The EUT was operating in controlled its channel.

Use the following spectrum analyzer settings:

- a) Set RBW = 100 kHz.
- b) Set the video bandwidth (VBW) ≥ 3*RBW.
- c) Detector = Peak.
- d) Trace mode = max hold.
- e) Sweep = auto couple.
- f) Allow the trace to stabilize.
- g) Measure the maximum width of the emission that is constrained by the frequencies associated with the two outermost amplitude points (upper and lower frequencies) that are attenuated by 6 dB relative to the maximum level measured in the fundamental emission.

7.3.6 Test Results

EUT:	Mobile Phone	Model No.:	GQ5002
Temperature:	20 ℃	Relative Humidity:	48%
Test Mode:	Mode2/Mode3/Mode4	Test By:	Mukzi Lee

Test data reference attachment.

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7.4 DUTY CYCLE

7.4.1 Applicable Standard

According to KDB 558074 D01 15.247 Meas Guidance v05r02s Section 6.

7.4.2 Conformance Limit

No limit requirement.

7.4.3 Measuring Instruments

The Measuring equipment is listed in the section 6.3 of this test report.

7.4.4 Test Setup

Please refer to Section 6.1 of this test report.

7.4.5 Test Procedure

The zero-span mode on a spectrum analyzer or EMI receiver if the response time and spacing between bins on the sweep are sufficient to permit accurate measurements of the on and off times of the transmitted signal. Set the center frequency of the instrument to the center frequency of the transmission. Set RBW \geq OBW if possible; otherwise, set RBW to the largest available value. Set VBW \geq RBW. Set detector = peak or average. The zero-span measurement method shall not be used unless both RBW and VBW are > 50/T and the number of sweep points across duration T exceeds 100. (For example, if VBW and/or RBW are limited to 3 MHz, then the zero-span method of measuring duty cycle shall not be used if T \leq 16.7 microseconds.)

The transmitter output is connected to the Spectrum Analyzer. We tested accroding to the zero-span measurement method, 6.0)b) in KDB 558074

The largest available value of RBW is 8 MHz and VBW is 50 MHz. The zero-span method of measuring duty cycle shall not be used if $T \le 6.25$ microseconds. (50/6.25 = 8)

The zero-span method was used because all measured T data are > 6.25 microseconds and both RBW and VBW are > 50/T.

The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator.

The path loss was compensated to the results for each measurement.

Set to the maximum power setting and enable the EUT transmit continuously.

The EUT was operating in controlled its channel.

Use the following spectrum analyzer settings:

Span = Zero Span

RBW = 8MHz(the largest available value)

 $VBW = 8MHz (\ge RBW)$

Number of points in Sweep >100

Detector function = peak

Trace = Clear write

Measure T_{total} and T_{on}

Calculate Duty Cycle = T_{on} / T_{total}

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7.4.6 Test Results

EUT:	Mobile Phone	Model No.:	GQ5002
Temperature:	20 ℃	Relative Humidity:	48%
Test Mode:	N/A	Test By:	N/A

Note: Not Applicable

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7.5 **PEAK OUTPUT POWER**

7.5.1 Applicable Standard

According to FCC Part 15.247(b)(3) and KDB 558074 D01 15.247 Meas Guidance v05r02 Section 8.3.1.

7.5.2 Conformance Limit

The maximum peak conducted output power of the intentional radiator for systems using digital modulation in the 2400 - 2483.5 MHz bands shall not exceed: 1 Watt (30dBm). If transmitting antenna of directional gain greater than 6dBi is used, the peak output power from the intentional radiator shall be reduced below the above stated value by the amount in dB that the directional gain of the antenna exceeds 6 dBi. In case of point-to-point operation, the limit has to be reduced by 1dB for every 3dB that the directional gain of the antenna exceeds 6dBi.

7.5.3 Measuring Instruments

The Measuring equipment is listed in the section 6.3 of this test report.

7.5.4 Test Setup

Please refer to Section 6.1 of this test report.

7.5.5 Test Procedure

The testing follows Subclause 11.9.1.1 of ANSI C63.10

The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator.

The path loss was compensated to the results for each measurement.

Set to the maximum power setting and enable the EUT transmit continuously.

The EUT was operating in controlled its channel.

Use the following spectrum analyzer settings:

Set the RBW ≧ DTS bandwidth.

Set VBW = 3*RBW.

Set the span ≥3*RBW

Set Sweep time = auto couple.

Set Detector = peak.

Set Trace mode = max hold.

Allow trace to fully stabilize.

Use peak marker function to determine the peak amplitude level.

7.5.6 Test Results

EUT:	Mobile Phone	Model No.:	GQ5002
Temperature:	20 ℃	Relative Humidity:	48%
Test Mode:	Mode2/Mode3/Mode4	Test By:	Mukzi Lee

Test data reference attachment.

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7.6 POWER SPECTRAL DENSITY

7.6.1 Applicable Standard

According to FCC Part 15.247(e) and KDB 558074 D01 15.247 Meas Guidance v05r02 Section 8.4.

7.6.2 Conformance Limit

The transmitter power spectral density conducted from the transmitter to the antenna shall not be greater than 8 dBm in any 3 kHz band during any time interval of continuous transmission.

7.6.3 Measuring Instruments

The Measuring equipment is listed in the section 6.3 of this test report.

7.6.4 Test Setup

Please refer to Section 6.1 of this test report.

7.6.5 Test Procedure

The testing follows Measurement Procedure Subclause 11.10.2 of ANSI C63.10

This procedure shall be used if maximum peak conducted output power was used to demonstrate compliance, and is optional if the maximum conducted (average) output power was used to demonstrate compliance.

The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator.

The path loss was compensated to the results for each measurement.

Set to the maximum power setting and enable the EUT transmit continuously.

The EUT was operating in controlled its channel.

- a) Set analyzer center frequency to DTS channel center frequency.
- b) Set the span to 1.5*DTS bandwidth.
- c) Set the RBW to: $3 \text{ kHz} \leq \text{RBW} \leq 100 \text{ kHz}$.
- d) Set the VBW \geq 3 RBW.
- e) Detector = peak.
- f) Sweep time = auto couple.
- g) Trace mode = max hold.
- h) Allow trace to fully stabilize.
- i) Use the peak marker function to determine the maximum amplitude level within the RBW.
- j) If measured value exceeds limit, reduce RBW (no less than 3 kHz) and repeat.

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7.6.6 Test Results

EUT:	Mobile Phone	Model No.:	GQ5002
Temperature:	20 ℃	Relative Humidity:	48%
Test Mode:	Mode2/Mode3/Mode4	Test By:	Mukzi Lee

Test data reference attachment.

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7.7 CONDUCTED BAND EDGE MEASUREMENT

7.7.1 Applicable Standard

According to FCC Part 15.247(d) and KDB 558074 D01 15.247 Meas Guidance v05r02 Section 8.7.

7.7.2 Conformance Limit

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB.

7.7.3 Measuring Instruments

The Measuring equipment is listed in the section 6.3 of this test report.

7.7.4 Test Setup

Please refer to Section 6.1 of this test report.

7.7.5 Test Procedure

The testing follows FCC KDB 558074 D01 15.247 Meas Guidance v05r02 Section 8.7.

The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator.

The path loss was compensated to the results for each measurement.

Set to the maximum power setting and enable the EUT transmit continuously.

The EUT was operating in controlled its channel.

Set RBW to 100 kHz and VBW of spectrum analyzer to 300 kHz with a convenient frequency span including 100 kHz bandwidth from band edge.

Measure the highest amplitude appearing on spectral display and set it as a reference level. Plot the graph with marking the highest point and edge frequency.

Repeat above procedures until all measured frequencies were complete.

7.7.6 Test Results

EUT:	Mobile Phone	Model No.:	GQ5002
Temperature:	20 ℃	Relative Humidity:	48%
Test Mode:	Mode2/Mode4	Test By:	Mukzi Lee

Test data reference attachment.

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7.8 SPURIOUS RF CONDUCTED EMISSIONS

7.8.1 Conformance Limit

- 1. Below -20dB of the highest emission level in operating band.
- 2. Fall in the restricted bands listed in section 15.205. The maximum permitted average field strength is listed in section 15.209.

7.8.2 Measuring Instruments

The Measuring equipment is listed in the section 6.3 of this test report.

7.8.3 Test Setup

Please refer to Section 6.1 of this test report.

7.8.4 Test Procedure

The Spurious RF conducted emissions compliance of RF radiated emission should be measured by following the guidance in ANSI C63.10-2013 with respect to maximizing the emission by rotating the EUT, measuring the emission while the EUT is situated in three orthogonal planes (if appropriate), adjusting the measurement antenna height and polarization etc. Set RBW=100kHz and VBW= 300KHz to measure the peak field strength, and measure frequency range from 30MHz to 26.5GHz.

7.8.5 Test Results

Remark: The measurement frequency range is from 30MHz to the 10th harmonic of the fundamental frequency. The lowest, middle and highest channels are tested to verify the spurious emissions and bandege measurement data.

Test data reference attachment.

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7.9 ANTENNA APPLICATION

7.9.1 Antenna Requirement

15.203 requirement: For intentional device, according to 15.203: an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

7.9.2 **Result**

The EUT antenna is permanent attached PIFA antenna (Gain: -0.6 dBi). It comply with the standard requirement.

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8 TEST RESULTS

8.1 **1M**

8.1.1 Maximum Conducted Output Power

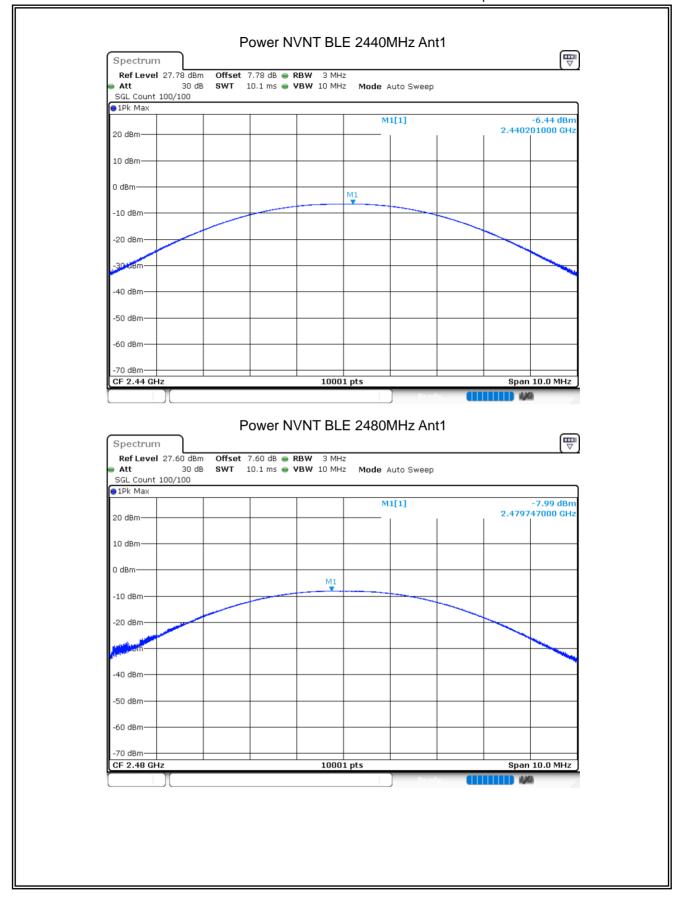
Condition	Mode	Frequency (MHz)	Antenna	Conducted Power (dBm)	Limit (dBm)	Verdict
NVNT	BLE	2402	Ant 1	-7.867	30	Pass
NVNT	BLE	2440	Ant 1	-6.442	30	Pass
NVNT	BLE	2480	Ant 1	-7.99	30	Pass

Power NVNT BLE 2402MHz Ant1 Spectrum Ref Level 27.62 dBm Offset 7.62 dB • RBW 3 MHz Att 30 dB SWT 10.1 ms - VBW 10 MHz Mode Auto Sweep SGL Count 200/200 ●1Pk Max M1[1] -7.87 dBm 2.402064000 GHz 20 dBm 10 dBm 0 dBm -10 dBm--20 dBm--40 dBm -60 dBm -70 dBm-CF 2.402 GHz 10001 pts Span 10.0 MHz

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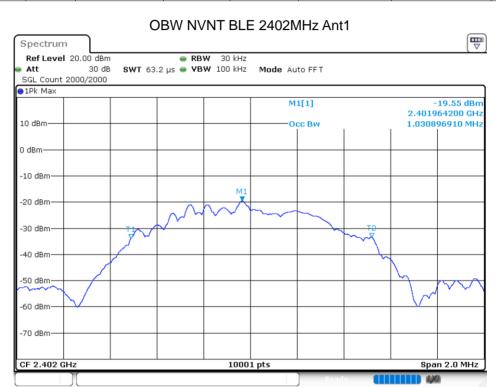
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8.1.2 Occupied Channel Bandwidth

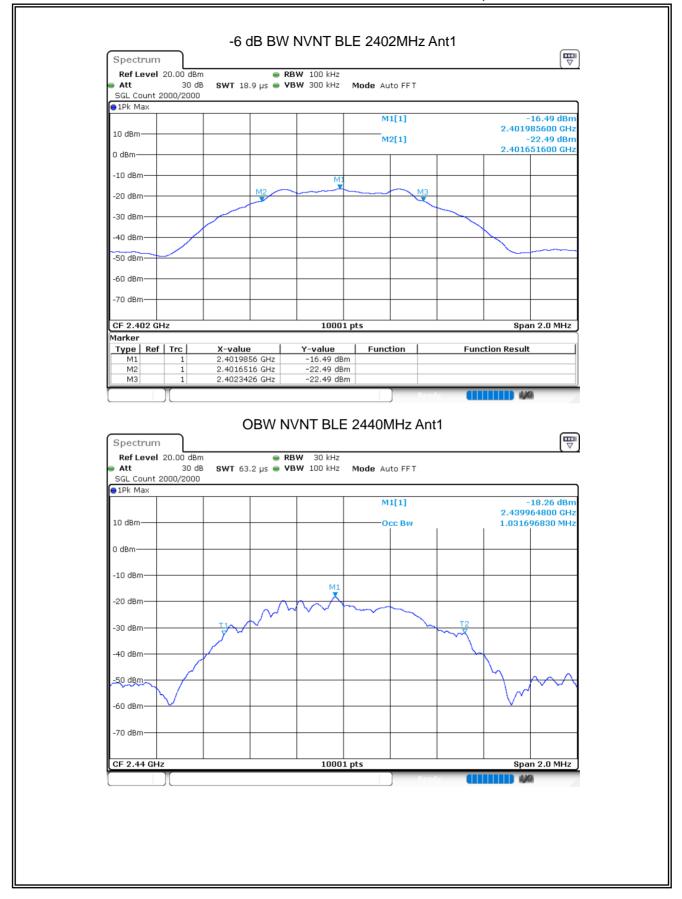
Condition	Mode	Frequency (MHz)	Antenna	99% OBW (MHz)	-6 dB Bandwidth (MHz)	Limit -6 dB Bandwidth (MHz)	Verdict
NVNT	BLE	2402	Ant 1	1.0309	0.691	0.5	Pass
NVNT	BLE	2440	Ant 1	1.0317	0.692	0.5	Pass
NVNT	BLE	2480	Ant 1	1.0321	0.6944	0.5	Pass



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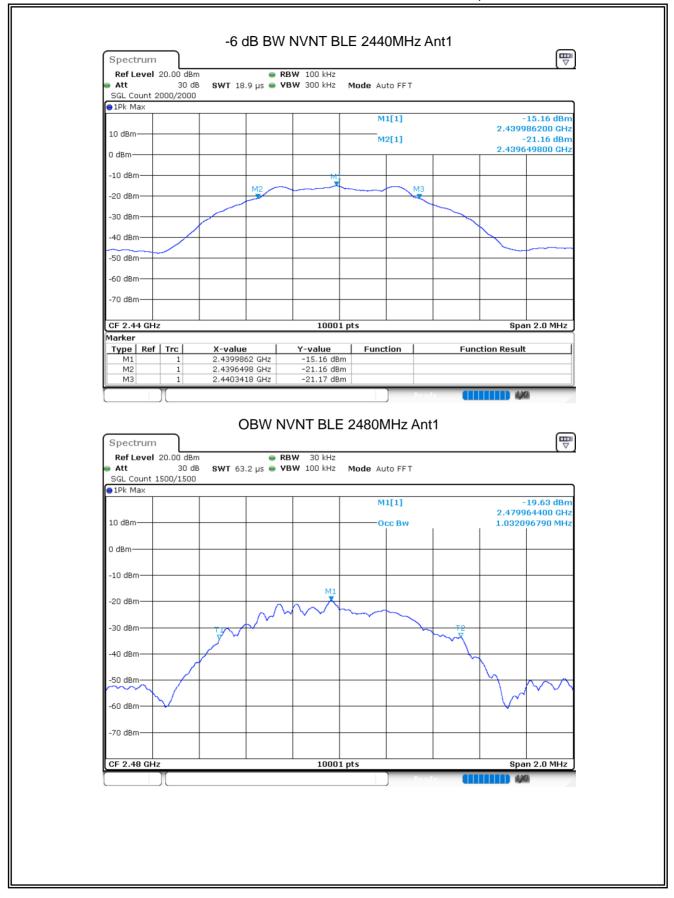




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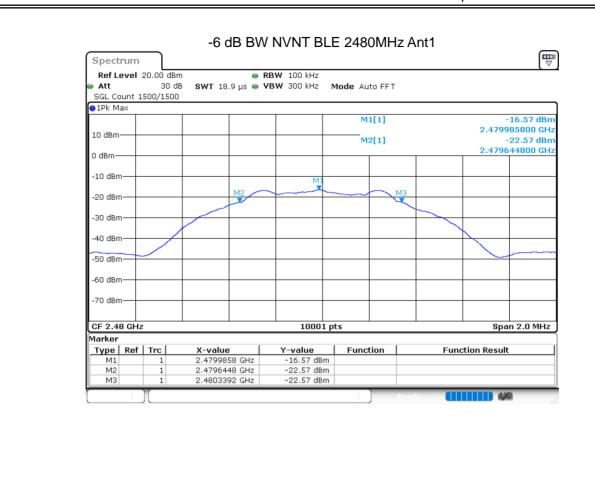




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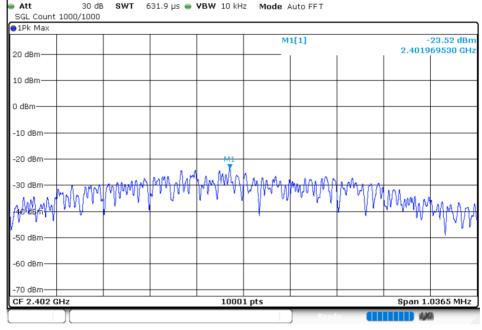




8.1.3 **Maximum Power Spectral Density Level**

Condition	Mode	Frequency (MHz)	Antenna	Max PSD (dBm/3kHz)	Limit (dBm/3kHz)	Verdict
NVNT	BLE	2402	Ant 1	-23.518	8	Pass
NVNT	BLE	2440	Ant 1	-22.041	8	Pass
NVNT	BLE	2480	Ant 1	-23.613	8	Pass

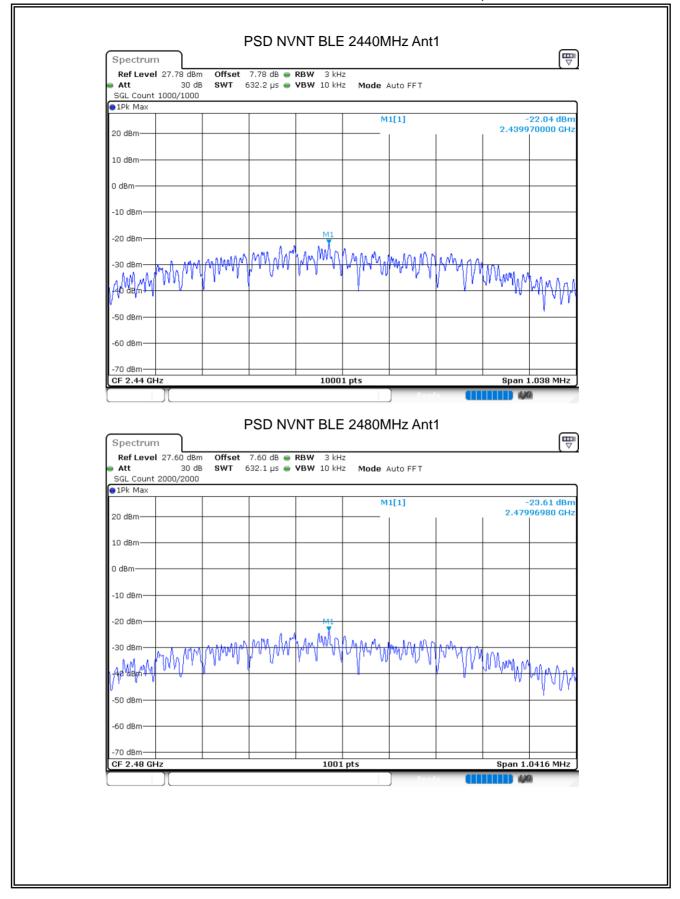
PSD NVNT BLE 2402MHz Ant1 Spectrum Ref Level 27.62 dBm Offset 7.62 dB • RBW 3 kHz 30 dB Att SWT 631.9 µs • VBW 10 kHz Mode Auto FFT SGL Count 1000/1000 ●1Pk Max M1[1] 20 dBm-



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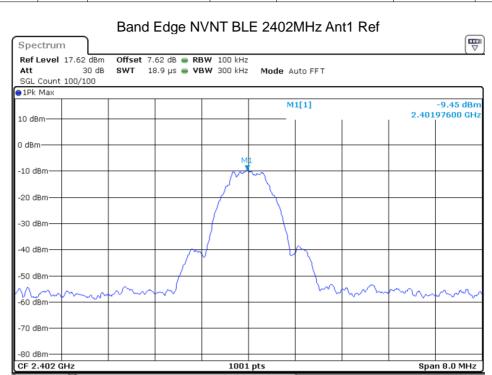
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8.1.4 Band Edge

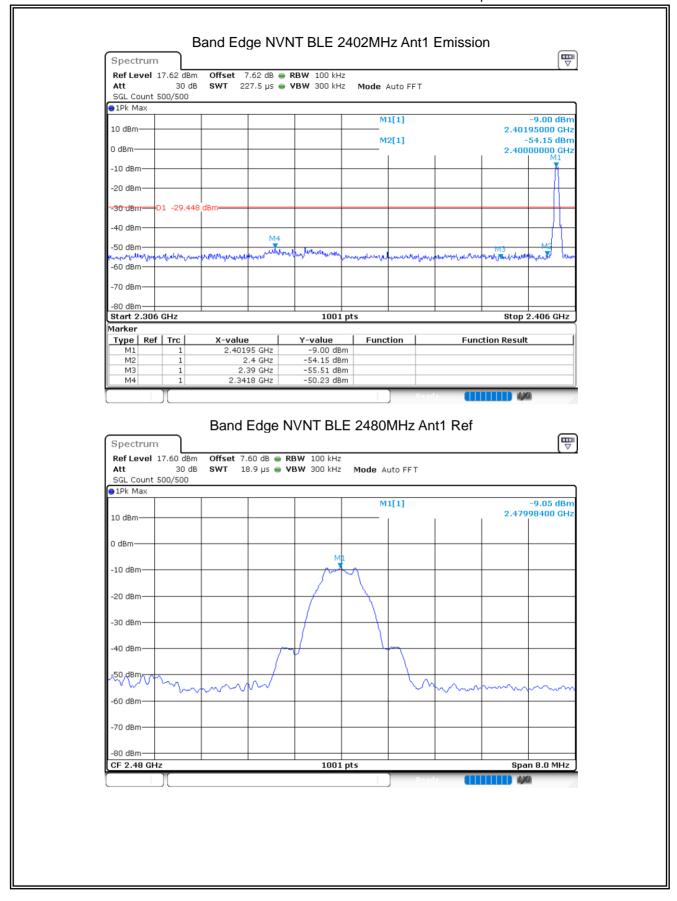
Condition	Mode	Frequency (MHz)	Antenna	Max Value (dBc)	Limit (dBc)	Verdict
NVNT	BLE	2402	Ant 1	-40.77	-20	Pass
NVNT	BLE	2480	Ant 1	-43.64	-20	Pass



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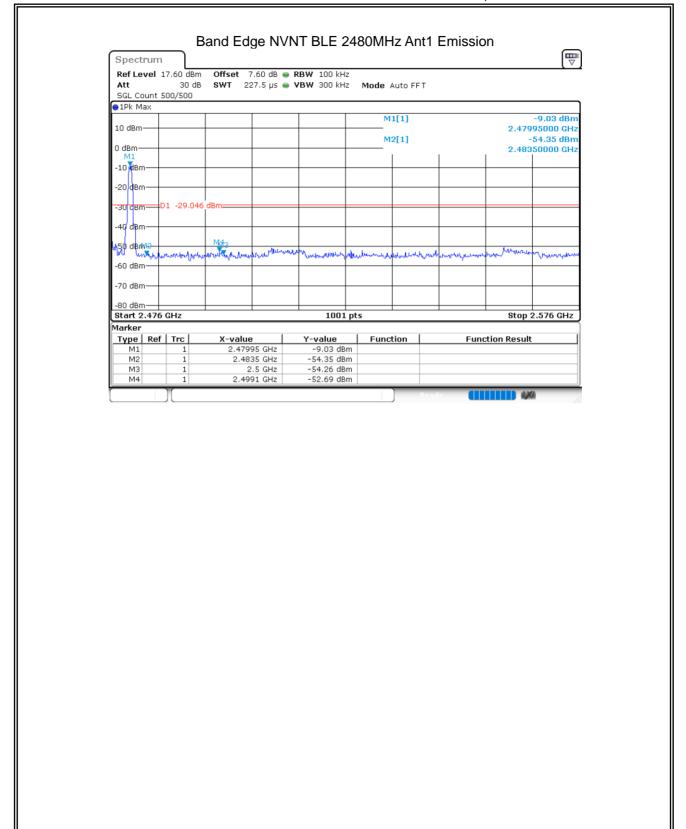




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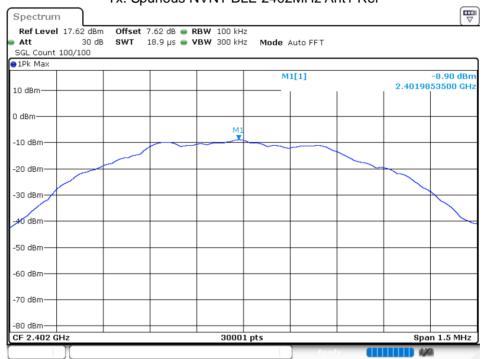




8.1.5 Conducted RF Spurious Emission

Condition	Mode	Frequency (MHz)	Antenna	Max Value (dBc)	Limit (dBc)	Verdict
NVNT	BLE	2402	Ant 1	-36.81	-20	Pass
NVNT	BLE	2440	Ant 1	-37.57	-20	Pass
NVNT	BLE	2480	Ant 1	-36.84	-20	Pass

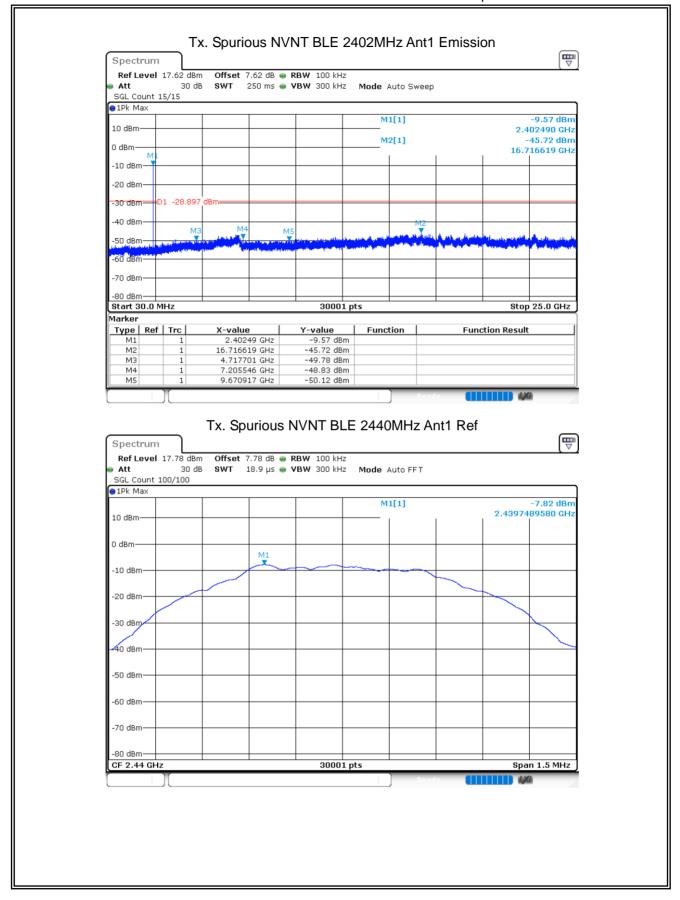
Tx. Spurious NVNT BLE 2402MHz Ant1 Ref



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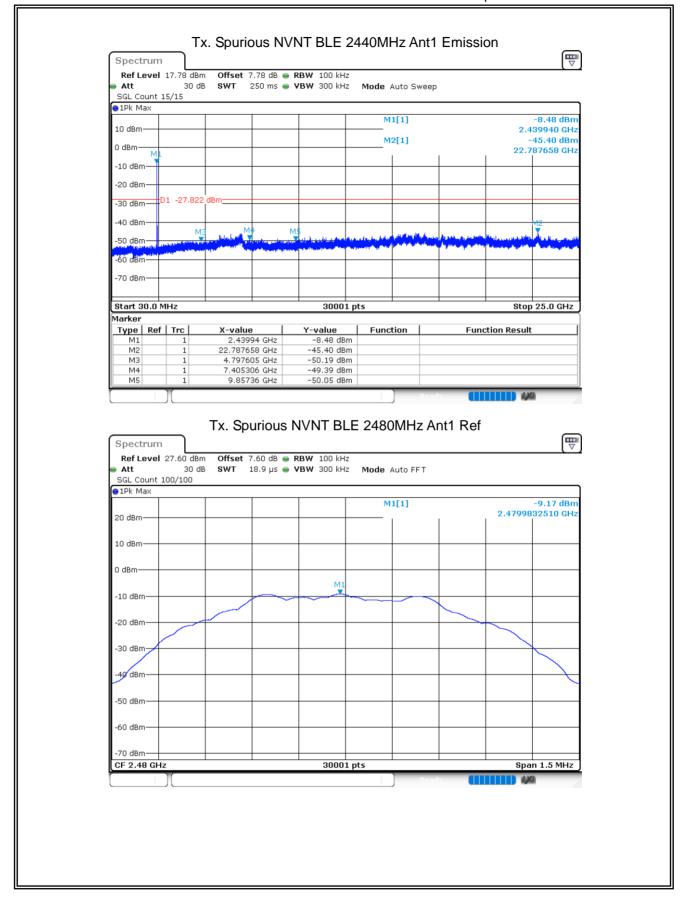




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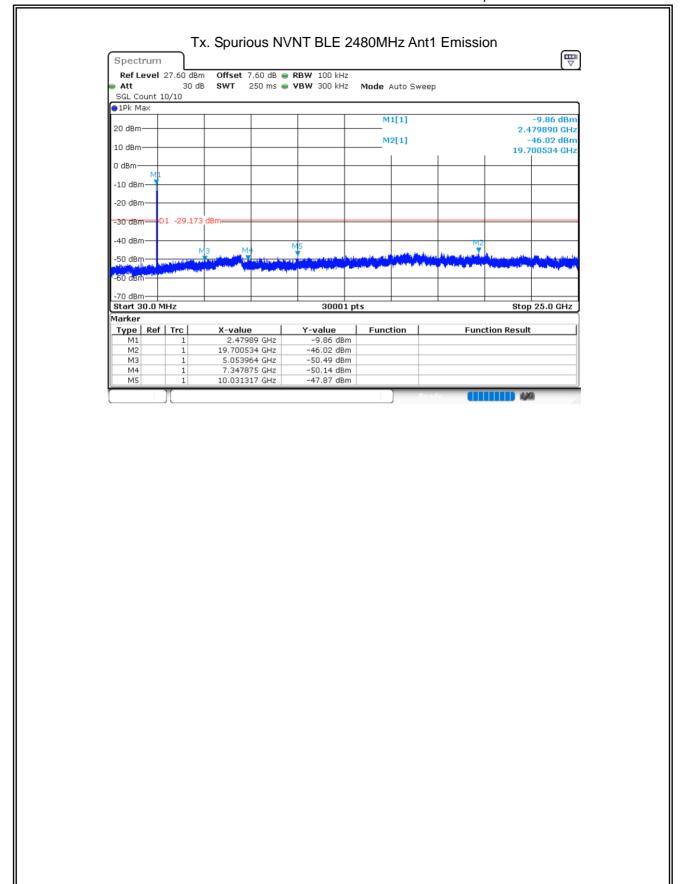




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Span 10.0 MHz



-70 dBm

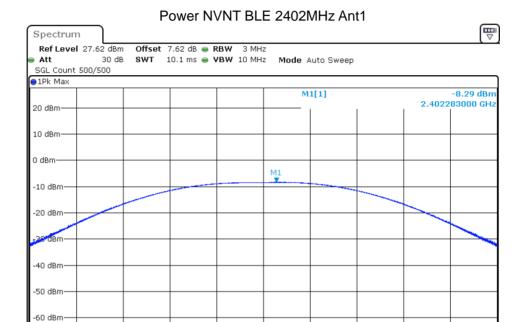
CF 2.402 GHz



8.2 **2M**

8.2.1 Maximum Conducted Output Power

Condition	Mode	Frequency (MHz)	Antenna	Conducted Power (dBm)	Limit (dBm)	Verdict
NVNT	BLE	2402	Ant 1	-8.293	30	Pass
NVNT	BLE	2440	Ant 1	-6.388	30	Pass
NVNT	BLE	2480	Ant 1	-7.374	30	Pass

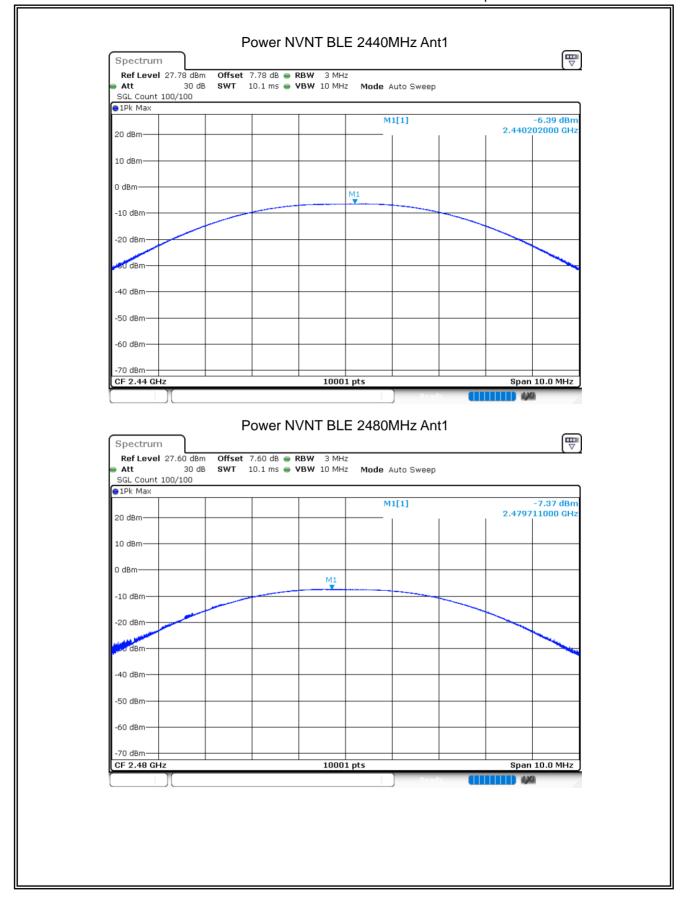


10001 pts

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8.2.2 Occupied Channel Bandwidth

Condi	tion	Mode	Frequency (MHz)	Antenna	99% OBW (MHz)	-6 dB Bandwidth (MHz)	Limit -6 dB Bandwidth (MHz)	Verdict
NVN	ΙT	BLE	2402	Ant 1	2.0582	1.1716	0.5	Pass
NVN	ΙΤ	BLE	2440	Ant 1	2.0566	1.138	0.5	Pass
NVN	ΙΤ	BLE	2480	Ant 1	2.0578	1.1596	0.5	Pass

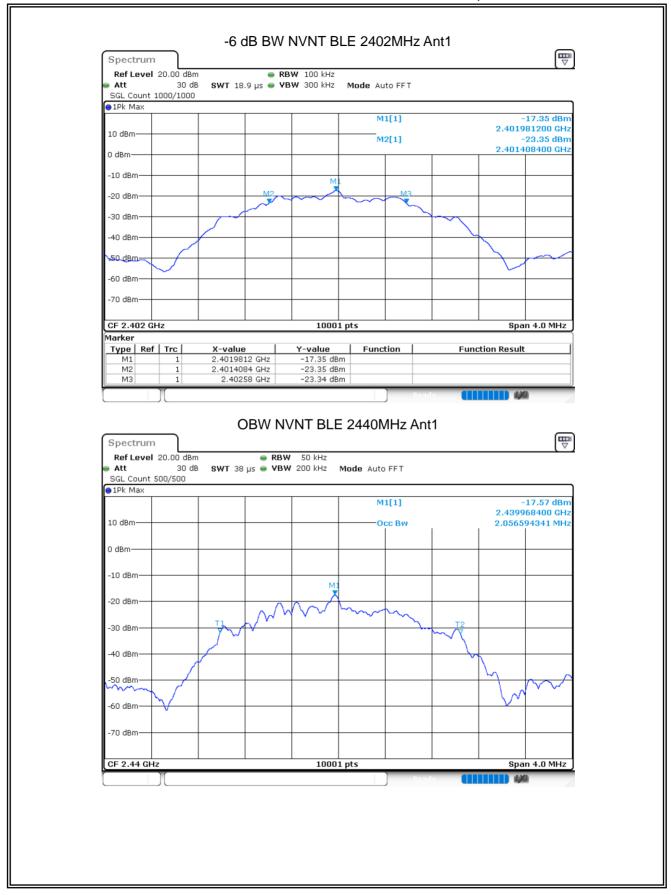
OBW NVNT BLE 2402MHz Ant1



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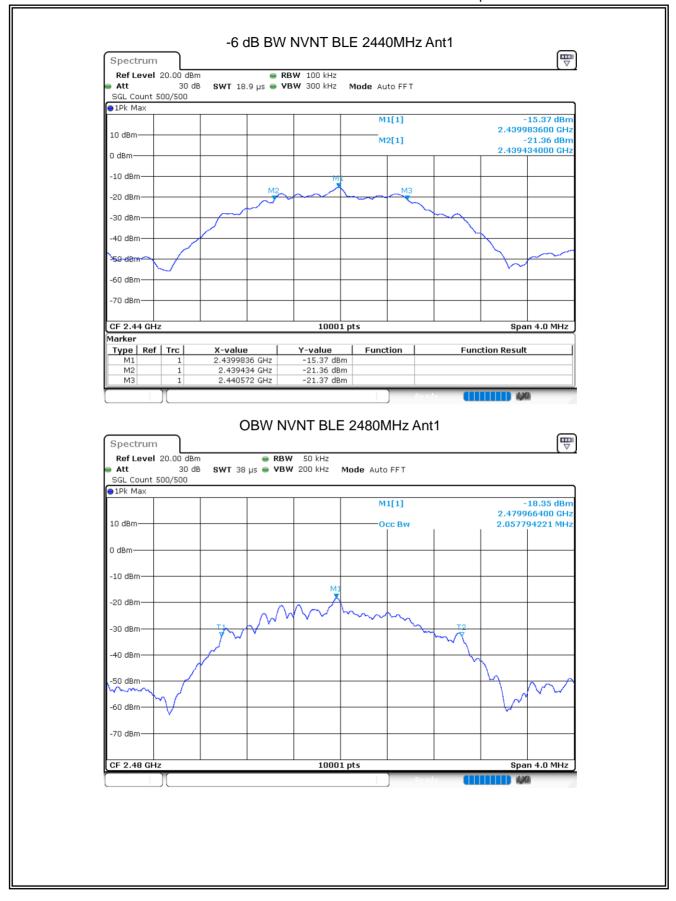




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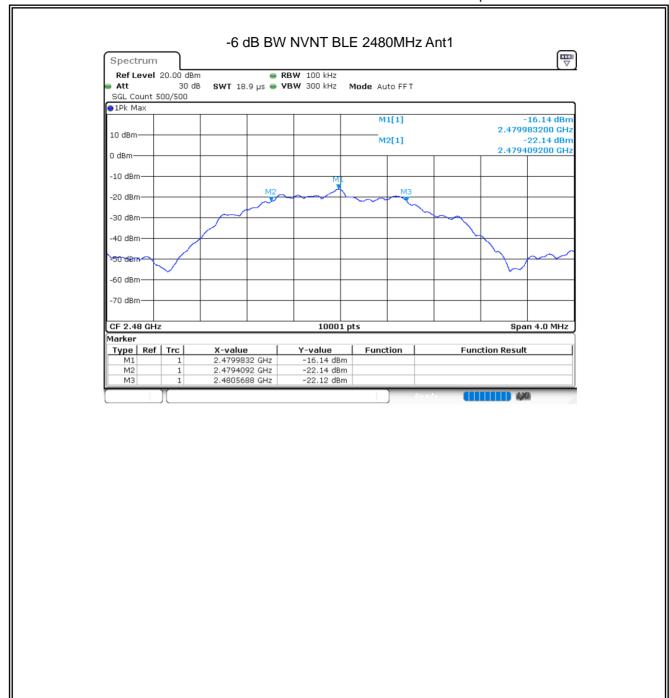




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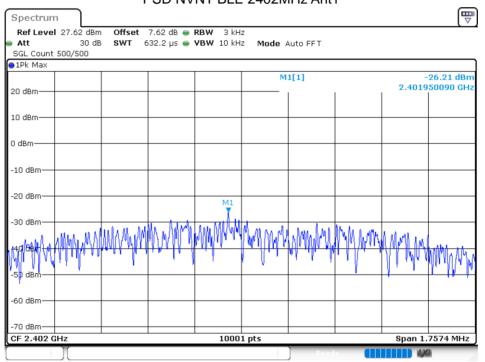




8.2.3 Maximum Power Spectral Density Level

Condition	Mode	Frequency (MHz)	Antenna	Max PSD (dBm/3kHz)	Limit (dBm/3kHz)	Verdict
NVNT	BLE	2402	Ant 1	-26.212	8	Pass
NVNT	BLE	2440	Ant 1	-24.209	8	Pass
NVNT	BLE	2480	Ant 1	-25.187	8	Pass

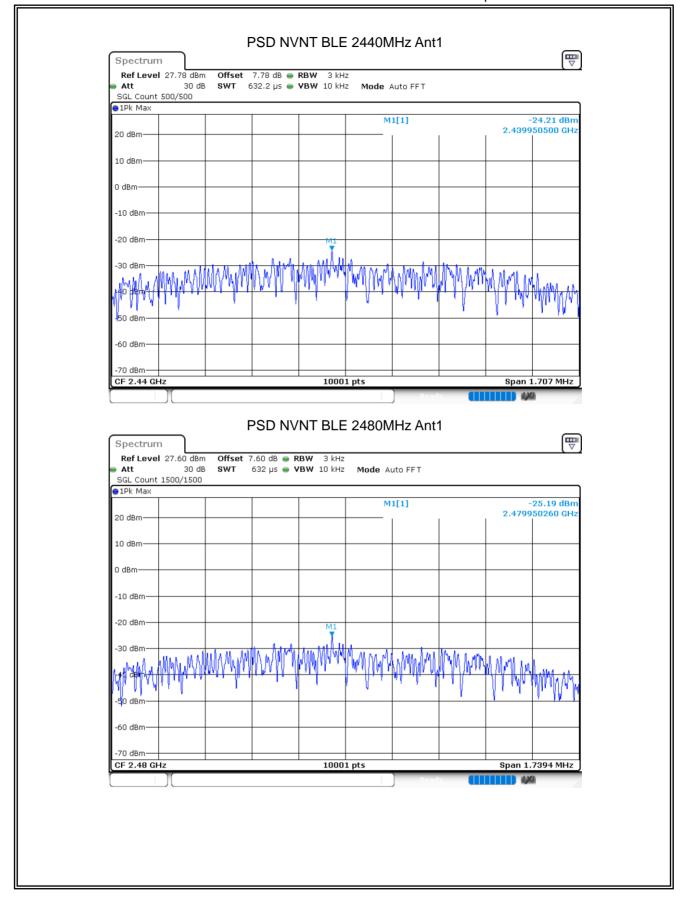
PSD NVNT BLE 2402MHz Ant1



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8.2.4 Band Edge

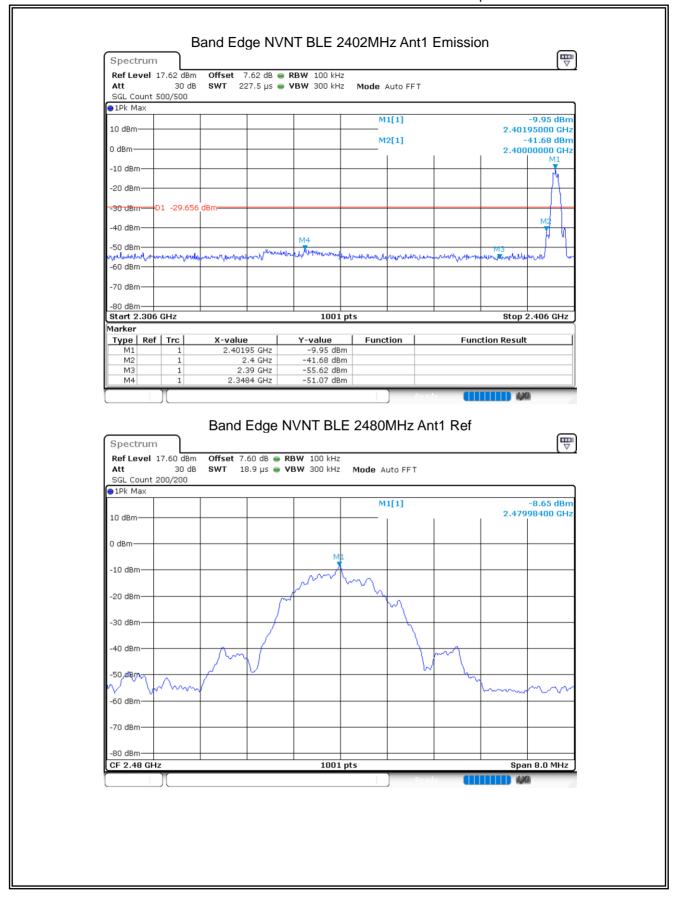
Condition	Mode	Frequency (MHz)	Antenna	Max Value (dBc)	Limit (dBc)	Verdict
NVNT	BLE	2402	Ant 1	-41.4	-20	Pass
NVNT	BLE	2480	Ant 1	-43.99	-20	Pass



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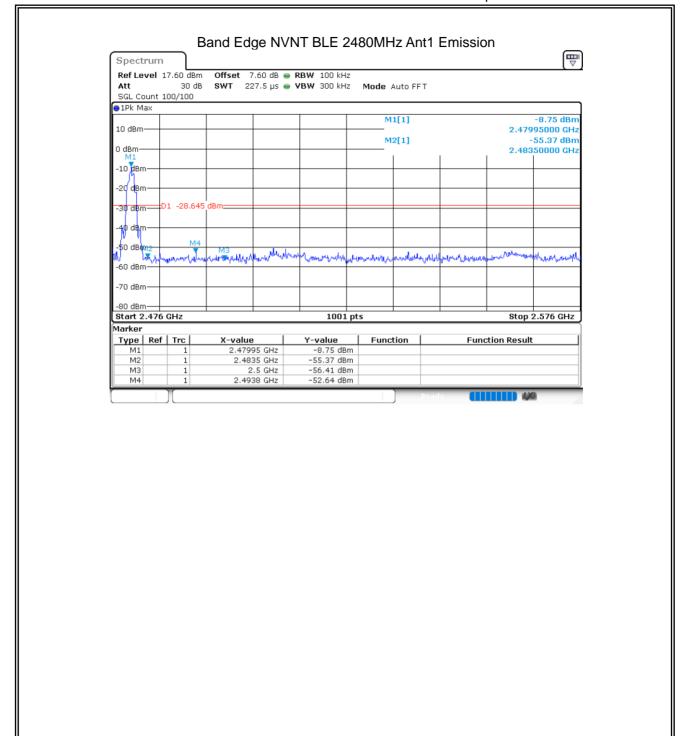




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8.2.5 Conducted RF Spurious Emission

Condition	Mode	Frequency (MHz)	Antenna	Max Value (dBc)	Limit (dBc)	Verdict
NVNT	BLE	2402	Ant 1	-36.21	-20	Pass
NVNT	BLE	2440	Ant 1	-37.8	-20	Pass
NVNT	BLE	2480	Ant 1	-35.3	-20	Pass

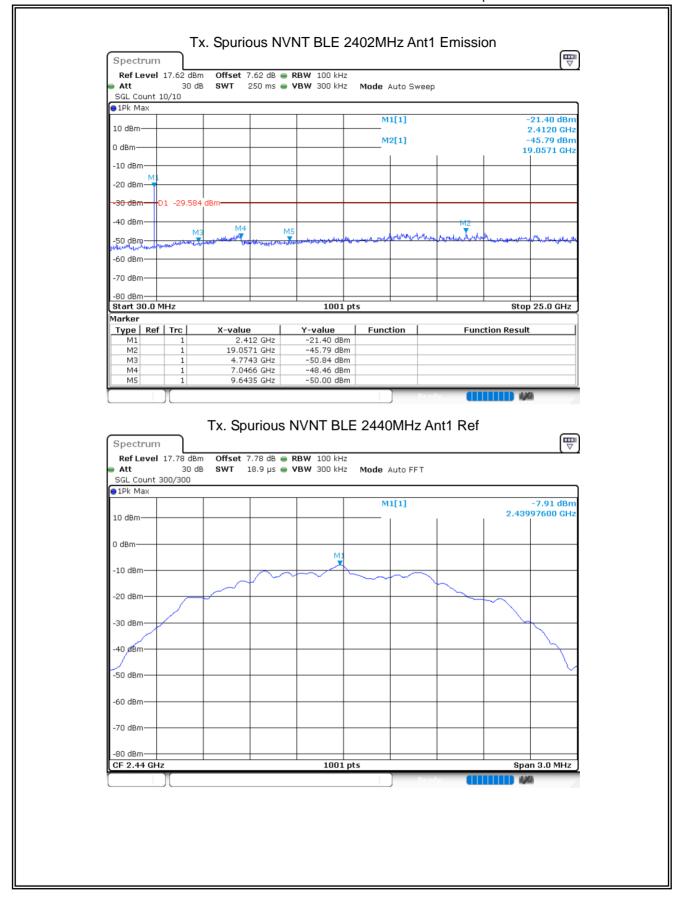




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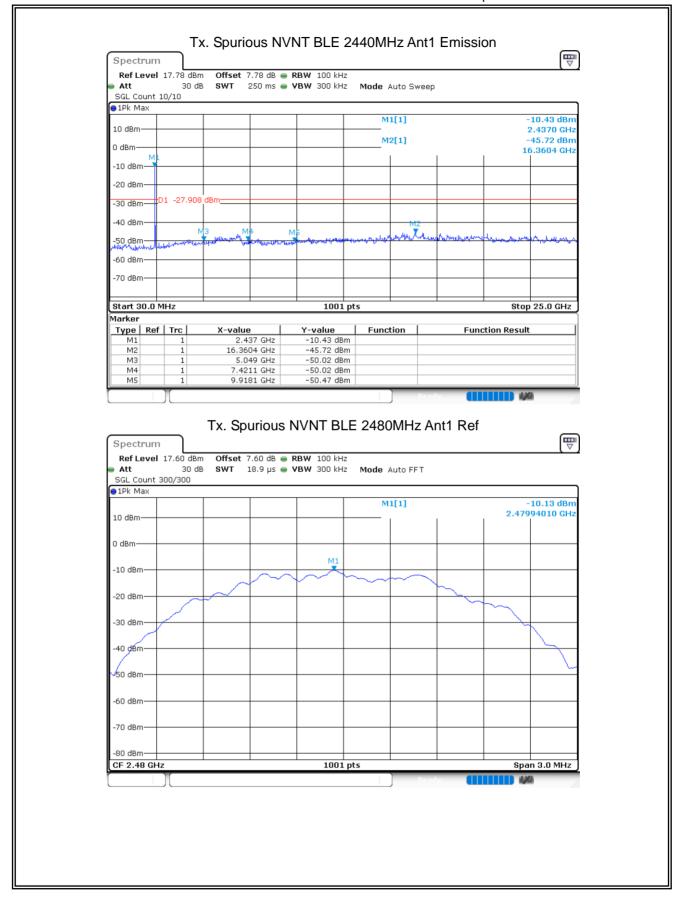




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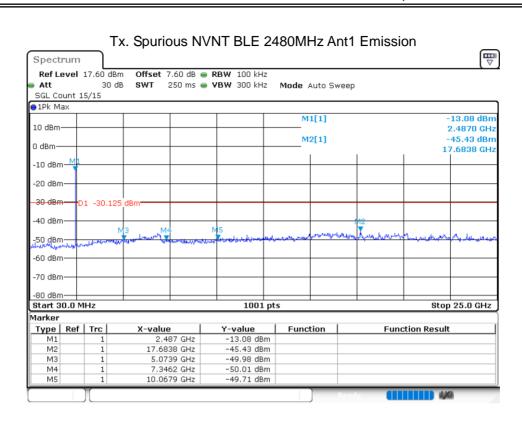




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END OF REPORT

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